### INTEGRATED CIRCUITS

# DATA SHEET

## 74ALS38A Quad 2-Input NAND buffer (open collector)

Product specification

1991 Feb 08

IC05 Data Handbook





### **Quad 2-input NAND buffer (open collector)**

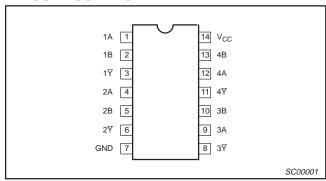
### **74ALS38A**

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74ALS38A	7.0ns	3.5mA

### **ORDERING INFORMATION**

	ORDER CODE		
DESCRIPTION	COMMERCIAL RANGE $V_{CC}$ = 5V $\pm 10\%$ , $T_{amb}$ = 0°C to $\pm 70$ °C	DRAWING NUMBER	
14-pin plastic DIP	74ALS38AN	SOT27-1	
14-pin plastic SO	74ALS38AD	SOT108-1	

#### **PIN CONFIGURATION**

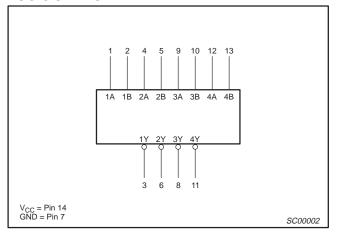


### INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

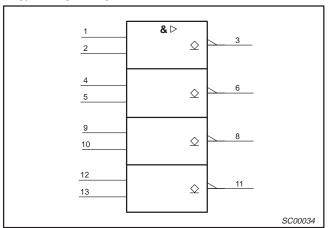
PINS	DESCRIPTION	74ALS (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
nA, nB	Data inputs	1.0/1.0	20μA/0.1mA
n∀	Data outputs	20/80	0.4mA/8mA

**NOTE**: One (1.0) ALS unit load is defined as: 20μA in the High state and 0.1mA in the Low state.

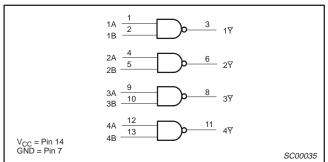
### **LOGIC SYMBOL**



### **IEC/IEEE SYMBOL**



### **LOGIC DIAGRAM**



### **FUNCTION TABLE**

INP	UTS	OUTPUT
nA	nB	nΫ
L	L	Н
L	Н	Н
Н	L	Н
Н	Н	L

H = High voltage level L = Low voltage level

X = Don't care

### Quad 2-input NAND buffer (open collector)

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#### **ABSOLUTE MAXIMUM RATINGS**

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V <sub>CC</sub>	Supply voltage	-0.5 to +7.0	V
V <sub>IN</sub>	Input voltage	-0.5 to +7.0	V
I <sub>IN</sub>	Input current	-30 to +5	mA
V <sub>OUT</sub>	Voltage applied to output in High output state	–0.5 to V <sub>CC</sub>	V
I <sub>OUT</sub>	Current applied to output in Low output state	48	mA
T <sub>amb</sub>	Operating free-air temperature range	0 to +70	°C
T <sub>stg</sub>	Storage temperature range	−65 to +150	°C

### RECOMMENDED OPERATING CONDITIONS

SYMBOL	DADAMETED		UNIT			
STWIBUL	PARAMETER	MIN	NOM	MAX	UNII	
V <sub>CC</sub>	Supply voltage	4.5	5.0	5.5	V	
V <sub>IH</sub>	High-level input voltage	2.0			V	
V <sub>IL</sub>	Low-level input voltage			0.8	V	
I <sub>Ik</sub>	Input clamp current			-18	mA	
V <sub>OH</sub>	High-level output voltage			5.5	V	
I <sub>OL</sub>	Low-level output current		·	24	mA	
T <sub>amb</sub>	Operating free-air temperature range	0		+70	°C	

### DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER		TEST CONDITION:		UNIT			
STWIBUL	PARAMETER		TEST CONDITION:	MIN	TYP <sup>2</sup>	MAX	UNII	
I <sub>OH</sub>	High-level output current		$V_{CC} = MIN, V_{IL} = MAX, V_{IH} = MIN$	N, V <sub>OH</sub> = MAX			100	μΑ
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	V I am land and a deal and		V <sub>CC</sub> = MIN, V <sub>IL</sub> = MAX,	I <sub>OL</sub> = 12mA		0.25	0.40	V
V <sub>OL</sub>	Low-level output voltage		$V_{IH} = MIN$ $I_{OL} = 24mA$			0.35	0.50	V
V <sub>IK</sub>	Input clamp voltage		$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.5	V
lı	Input current at maximum input v	oltage	$V_{CC} = MAX, V_I = 7.0V$				0.1	mA
I <sub>IH</sub>	High-level input current		$V_{CC} = MAX, V_I = 2.7V$				20	μΑ
I <sub>IL</sub>	Low-level input current		$V_{CC} = MAX, V_I = 0.5V$				-0.1	mA
1	Cumply ourrent (total)	I <sub>CCH</sub>	V <sub>CC</sub> = MAX	V <sub>I</sub> = GND		0.65	1.6	mA
I <sub>CC</sub>	Supply current (total) I <sub>CCL</sub>			V <sub>I</sub> = 4.5V		6.5	9.0	mA

#### NOTES:

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<sup>1.</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

<sup>2.</sup> All typical values are at  $V_{CC}$  = 5V,  $T_{amb}$  = 25°C.

### Quad 2-input NAND buffer (open collector)

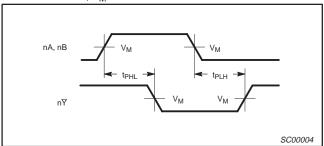
**74ALS38A** 

#### **AC ELECTRICAL CHARACTERISTICS**

			LIM	ITS	
SYMBOL	PARAMETER	TEST CONDITION	T <sub>amb</sub> = 0°C V <sub>CC</sub> = +5. C <sub>L</sub> = 50pF,		UNIT
			MIN	MAX	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay nA or nB to $\overline{\text{nY}}$	Waveform 1	3.0 3.0	11.0 11.0	ns

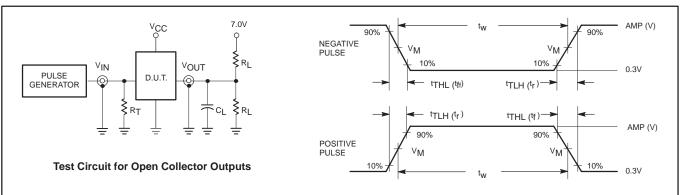
### **AC WAVEFORMS**

For all waveforms,  $V_M = 1.3V$ .



Waveform 1. Propagation Delay for Data to Output

### **TEST CIRCUIT AND WAVEFORMS**



#### **DEFINITIONS:**

R<sub>L</sub> = Load resistor;

see AC electrical characteristics for value.

C<sub>L</sub> = Load capacitance includes jig and probe capacitance; see AC electrical characteristics for value.

 $R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

Innut	Dulco	Definition
Input	Puise	Definition

Family		INPUT	PULSE RE	QUIREN	MENTS	
Family	Amplitude	$V_{\text{M}}$	Rep.Rate	t <sub>w</sub>	t <sub>TLH</sub>	t <sub>THL</sub>
74ALS	3.5V	1.3V	1MHz	500ns	2.0ns	2.0ns

SC00036

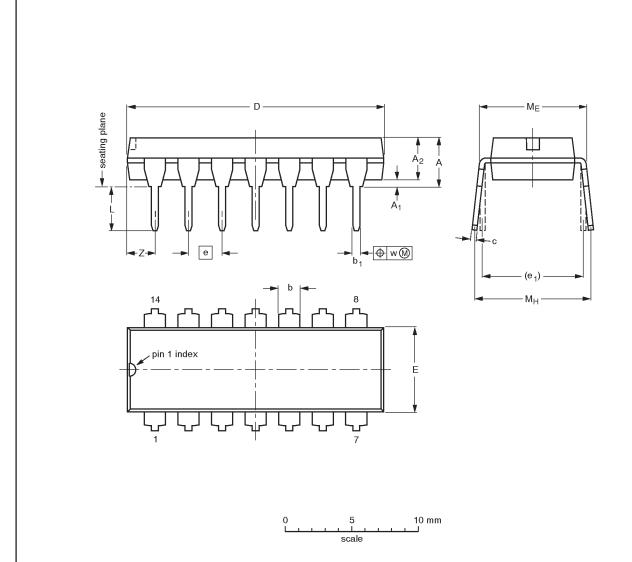
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### Quad 2-input NAND buffer (open collector)

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### DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



### DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	ME	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.020	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT27-1	050G04	MO-001AA			<del>92-11-17</del> 95-03-11	

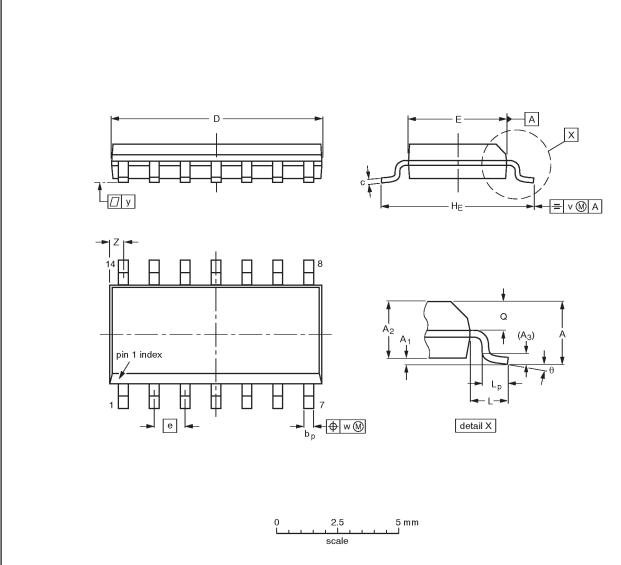
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### Quad 2-input NAND buffer (open collector)

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### SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



### DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	<b>A</b> <sub>3</sub>	bр	c	D <sup>(1)</sup>	E <sup>(1)</sup>	Φ	HE	٦	Lp	Ø	٧	w	у	Z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.0098 0.0039		0.01		0.0098 0.0075	0.35 0.34	0.16 0.15	0.050	0.24 0.23	0.041			0.01	0.01	0.004	0.028 0.012	0°

#### Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT108-1	076E06\$	MS-012AB				<del>91-08-13</del> 95-01-23	

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### Quad 2-input NAND buffer (open collector)

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DEFINITIONS						
Data Sheet Identification	Product Status	Definition				
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.				
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